Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/715,376	SUN ET AL.
Examiner	Art Unit
Thinh T. Nguyen	2818

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARCH	TES STRATEGY)
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